Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination		
10540311	AUGUSTUS ET AL.		
Examiner	Art Unit		
Young J Kim	1637		

SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES				
Search Notes	Date	Examiner		
re-reviewed the STIC-assisted search of SEQ ID Numbers 1 and 7	5/29/2009	/YJK/		
STIC- search reviewed	1/8/2010	/YJK/		
Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB) - see enclosed for text-search strategy	1/8/2010	/YJK/		
updated	8/2/2010	/YJK/		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
	Interference search history - see enclosed	1/8/2010	/YJK/		

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